

# Control of Graphene's Electrical Properties by Chemical Doping Methods

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This study examined the synthesis of large area graphene and the change of its characteristics depending on the ratio of CH<sub>4</sub>/H<sub>2</sub> by using the thermal CVD methods and performed the experiments to control the electron-hole conduction and Dirac-point of graphene by using chemical doping methods. Firstly, with regard to the characteristics of the large area graphene depending on the ratio of CH<sub>4</sub>/H<sub>2</sub>, hydrophobic characteristics of the graphene changed to hydrophilic characteristics as the ratio of CH<sub>4</sub>/H<sub>2</sub> reduces. The angle of contact also increased to 78° from 58°. According to the results of Raman spectroscopy showing the degree of defect, the ratio of I(D)/I(G) increases to 0.42% from 0.25% and the surface resistance also increased to 950 Ω/sq from 750 Ω/sq. As for the graphene synthesis at the high temperature of 1,000° by using CH<sub>4</sub>/H<sub>2</sub> in a Cu-Foil, the possibility of graphene formation was determined as a function of the ratio of H<sub>2</sub> included in the fixed quantity of CH<sub>4</sub> as per specifications of every equipment. It was observed that the excessive amount of H<sub>2</sub> prevented graphene from forming, as extra H-atoms and molecules activated the reaction to C-bond of graphene. Secondly, in the experiment for the electron-hole conduction and the Dirac-point of graphene using the chemical doping method, the shift of Dirac-point and the change in the electron-hole conduction were observed for both the N-type (PEI) and the P-type (Diazonium) dopings. The ID-VG results show that, for the N-type (PEI) doped graphene, Dirac-point shifted to the left (-voltage direction) by 90V at an hour and by 130 V at 2 hours respectively, compared to the pristine graphene. Carrier mobility was also reduced by 1,600 cm<sup>2</sup>/Vs (1 hour) and 1,100 cm<sup>2</sup>/Vs (2 hours), compared to the maximum hole mobility of the pristine graphene.

**Keywords:** CVD graphene FET, P&N type doping graphene, Electrical Properties of graphene